

MAXIMUM RATINGS

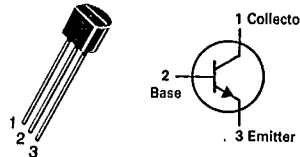
Rating	Symbol	BC 485	BC 487	BC 489	Unit
Collector-Emitter Voltage	V _{CEO}	45	60	80	V _{dc}
Collector-Base Voltage	V _{CBO}	45	60	80	V _{dc}
Emitter-Base Voltage	V _{EBO}	5.0			V _{dc}
Collector Current - Continuous	I _C	0.5			A _{dc}
Total Device Dissipation @ T _A = 25°C Derate above 25°C	P _D	625	5.0		mW mW/°C
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	1.5	12		Watt mW/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-55 to +150			°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R _{θJC}	83.3	°C/W
Thermal Resistance, Junction to Ambient	R _{θJA}	200	°C/W

BC485, A, B, L
BC487, A, B, L
BC489, A, B, L

CASE 29-04, STYLE 17
TO-92 (TO-226AA)



HIGH CURRENT TRANSISTORS

NPN SILICON

Refer to MPSA05 for graphs.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage* (I _C = 10 mA _{dc} , I _B = 0)	V _{(BR)CEO}	45 60 80	— — —	— — —	V _{dc}
Collector-Base Breakdown Voltage (I _C = 100 μA _{dc} , I _E = 0)	V _{(BR)CBO}	45 60 80	— — —	— — —	V _{dc}
Emitter-Base Breakdown Voltage (I _E = 10 μA _{dc} , I _C = 0)	V _{(BR)EBO}	5.0	—	—	V _{dc}
Collector Cutoff Current V _{CB} = 30 V _{dc} - I _E = 0 V _{CB} = 40 V _{dc} - I _E = 0 V _{CB} = 60 V _{dc} - I _E = 0	I _{CBO}	— — —	— — —	100 100 100	nA _{dc}

ON CHARACTERISTICS*

DC Current Gain (I _C = 10 mA _{dc} - V _{CE} = 2.0 V _{dc}) (I _C = 100 mA _{dc} - V _{CE} = 2.0 V _{dc})	h _{FE}	40			
		60		400	
		60	120	150	
		100	160	250	
		160	260	400	
		15			
Collector Emitter Saturation Voltage (I _C = 500 mA _{dc} - I _B = 50 mA _{dc}) (I _C = 1 A _{dc} - I _B = 100 mA _{dc})	V _{CE(sat)}	— —	0.2 0.3	0.50 —	V _{dc}
Base Emitter Saturation Voltage (I _C = 500 mA _{dc} , I _B = 50 mA _{dc}) (I _C = 1 A _{dc} - I _B = 100 mA _{dc})*	V _{BE(sat)}	—	0.85 0.90	1.20	V _{dc}

DYNAMIC CHARACTERISTICS

Current-Gain-Bandwidth Product (I _C = 50 mA _{dc} , V _{CE} = 2.0 V _{dc} , f = 100 MHz)	f _T	—	200	—	MHz
Output Capacitance (V _{CB} = 10 V _{dc} , I _E = 0, f = 1.0 MHz)	C _{ob}	—	7	—	pF
Input Capacitance (V _{BE} = 0.5 V _{dc} , I _C = 0, f = 1.0 MHz)	C _{ib}	—	50	—	pF

* Pulse test - Pulse width = 300 μs - Duty Cycle 2%.